# Power MOSFET

# 30 V, 90 A, Single N-Channel, SO-8FL

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

### **Applications**

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
Gate-to-Source Vol	Gate-to-Source Voltage			±20	V
Continuous Drain Current R <sub>BJA</sub>		T <sub>A</sub> = 25°C	I <sub>D</sub>	18	Α
(Note 1)		T <sub>A</sub> = 85°C		13	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.25	W
Continuous Drain Current R <sub>0JA</sub>		T <sub>A</sub> = 25°C	ID	11	Α
(Note 2)	Steady State	T <sub>A</sub> = 85°C		8	
Power Dissipation R <sub>0JA</sub> (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.89	W
Continuous Drain Current R <sub>BJC</sub>		T <sub>C</sub> = 25°C	I <sub>D</sub>	90	Α
(Note 1)		T <sub>C</sub> = 85°C		65	
Power Dissipation R <sub>0JC</sub> (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	55.6	W
Pulsed Drain Current	$T_A = 25^{\circ}C,$ $t_p = 10 \ \mu s$		I <sub>DM</sub>	180	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	46	Α
Drain to Source DV/DT			dV/dt	6	V/ns
Single Pulse Drain-to-Source Avalanche Energy ( $T_J$ = 25°C, $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_L$ = 22 $A_{pk}$ , $L$ = 1.0 mH, $R_G$ = 25 $\Omega$ )			EAS	242	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

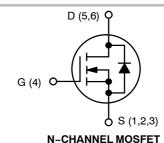
- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.



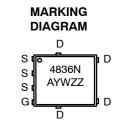
### ON Semiconductor®

### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
	4.0 mΩ @ 10 V	
30 V	6.0 mΩ @ 4.5 V	90 A







A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4836NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4836NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.25	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	55.6	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	140.8	

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				25		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 25 °C				1	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.5		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V to	I <sub>D</sub> = 30 A		2.8	4.0	
		11.5 V V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 15 A		2.8		1 !
			I <sub>D</sub> = 30 A		4.8	6.0	mΩ
			I <sub>D</sub> = 15 A		4.8		,
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A			24		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE					•	•
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 12 V			2677		pF
Output Capacitance	C <sub>OSS</sub>				565		
Reverse Transfer Capacitance	C <sub>RSS</sub>				307		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			20	28	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				3.2		
Gate-to-Source Charge	Q <sub>GS</sub>				8.0		
Gate-to-Drain Charge	$Q_{GD}$				8.0		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 11.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			45		nC
SWITCHING CHARACTERISTICS (Note 6)	•					•	•
Turn-On Delay Time	t <sub>d(ON)</sub>				14		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			30		- ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				20		
Fall Time	t <sub>f</sub>				12		1
Turn-On Delay Time	t <sub>d(ON)</sub>				8.0		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $I_{G}$ = 3.0 $\Omega$			27		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				31		ns
Fall Time	t <sub>f</sub>				7.0		

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

<sup>5.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTE	RISTICS	-					
Forward Diode Voltage	rward Diode Voltage V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.83	1.2	.,,
		$V_{GS} = 0 \text{ V},$ $I_S = 30 \text{ A}$ $I_J = 25^{\circ}$	T <sub>J</sub> = 125°C		0.7		·
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 30 A			27.1		ns
Charge Time	t <sub>a</sub>				13.8		
Discharge Time	t <sub>b</sub>				13.3		
Reverse Recovery Charge	$Q_{RR}$				16		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			0.65		nH
Drain Inductance	L <sub>D</sub>				0.005		nH
Gate Inductance	L <sub>G</sub>				1.84		nH
Gate Resistance	$R_{G}$				1.2		Ω

### TYPICAL PERFORMANCE CURVES

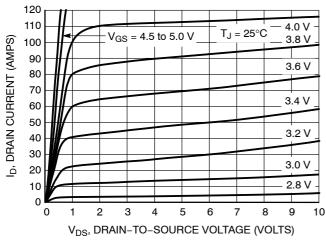


Figure 1. On–Region Characteristics

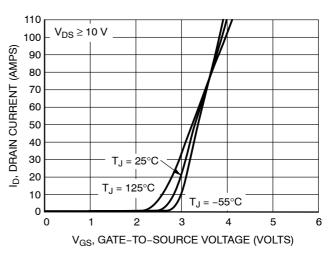


Figure 2. Transfer Characteristics

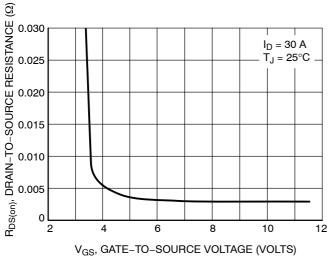


Figure 3. On-Resistance vs. Gate-to-Source Voltage

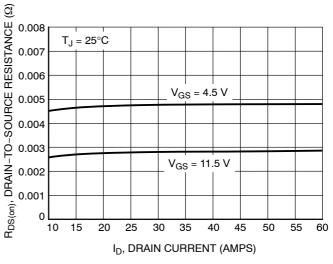


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

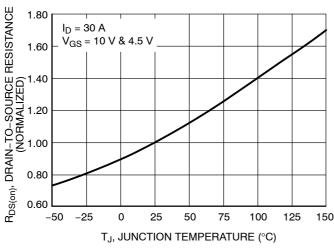


Figure 5. On–Resistance Variation with Temperature

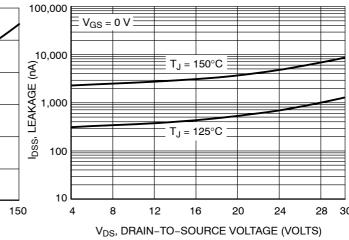
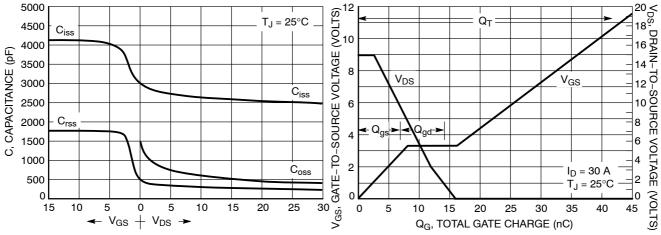


Figure 6. Drain-to-Source Leakage Current vs. Voltage

### TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

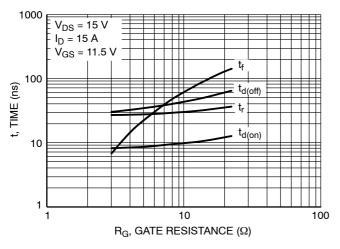


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

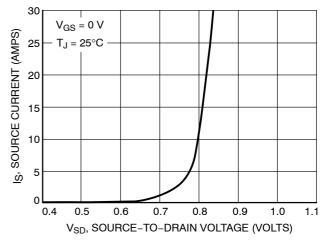


Figure 10. Diode Forward Voltage vs. Current

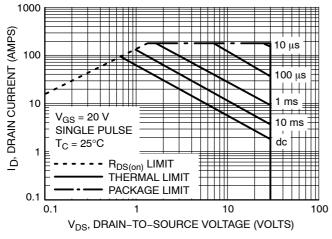


Figure 11. Maximum Rated Forward Biased Safe Operating Area

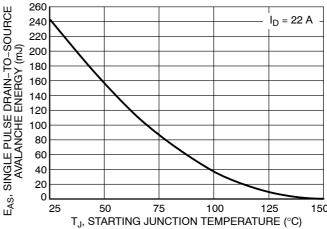


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

# **TYPICAL PERFORMANCE CURVES**

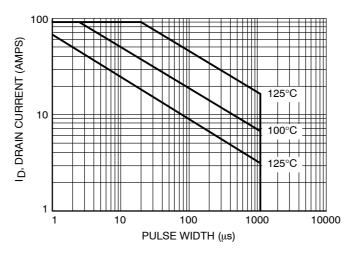


Figure 13. Avalanche Characteristics





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

### **DATE 25 JUN 2018**

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC			
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
M	3.00	3.40	3.80		
θ	0 °		12 °		

### **GENERIC MARKING DIAGRAM\***

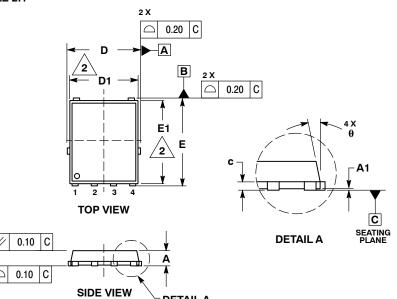


XXXXXX = Specific Device Code

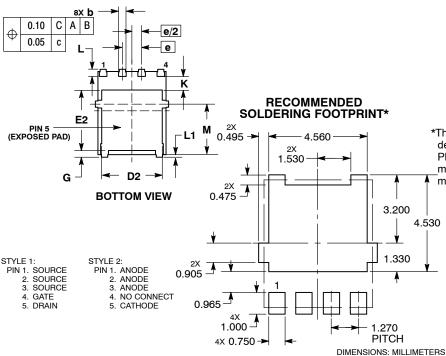
= Assembly Location Α

Υ = Year W = Work Week = Lot Traceability ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.



**DETAIL** A



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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